


<b>Search Notes</b> 	<b>Application/Control No.</b> 09818260	<b>Applicant(s)/Patent Under Reexamination</b> SCHORK ET AL.
	<b>Examiner</b> Lin, Jerry	<b>Art Unit</b> 1631

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
WEST, Google Scholar: likelihood, haplotype, statistical, significance, frequency, E-M algorithms, omnibus tests, permutations/	1/18/2007	JL
Inventor Search	1/18/2007	JL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner